

Search Notes**Application/Control No.**

10/564,545

Examiner

LAN VINH

**Applicant(s)/Patent under
Reexamination**

SPITZ ET AL.

Art Unit

1713

SEARCHED

Class	Subclass	Date	Examiner
216	2,17,18,39	6/15/2010	LV
156	345,17;	6/15/2010	LV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
key word search (USPAT,USPGPUB,USOCR,JPO,EP O,DERWENT,IBM) in EAST , inventor search	6/15/2010	LV